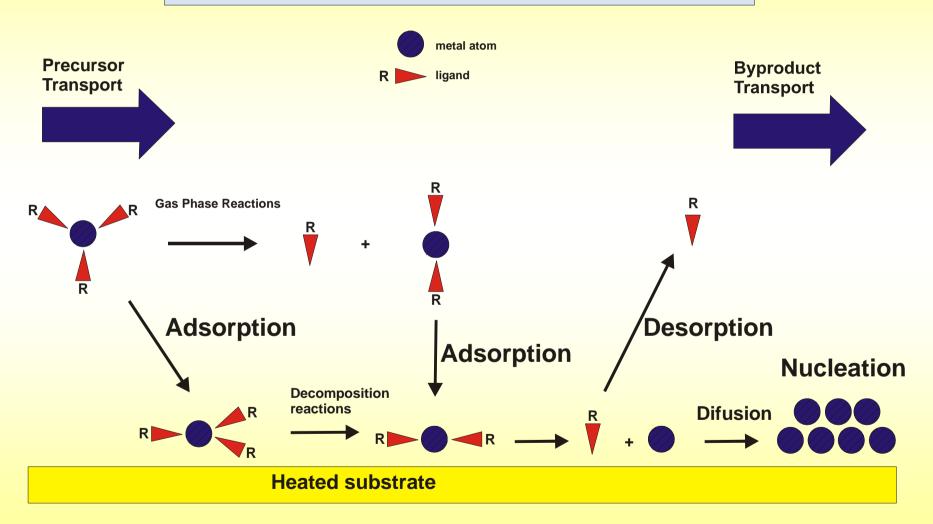
Basic steps in the CVD process



CVD

1

Aluminum

 $2.27 \mu\Omega$ cm, easily etched, Al dissolves in Si,

 $GaAs + Al \longrightarrow AlAs + Ga$

Gas diffusion barriers, Al on polypropylene, food packaging = chip bags, party balloons, high optical reflectivity

TIBA

Al deposits selectively on Al surfaces, not on SiO₂
Laser-induced nucleation
248 nm only surface adsorbates pyrolysed
193 nm gas phase reactions, loss of spatial selectivity control

TMA

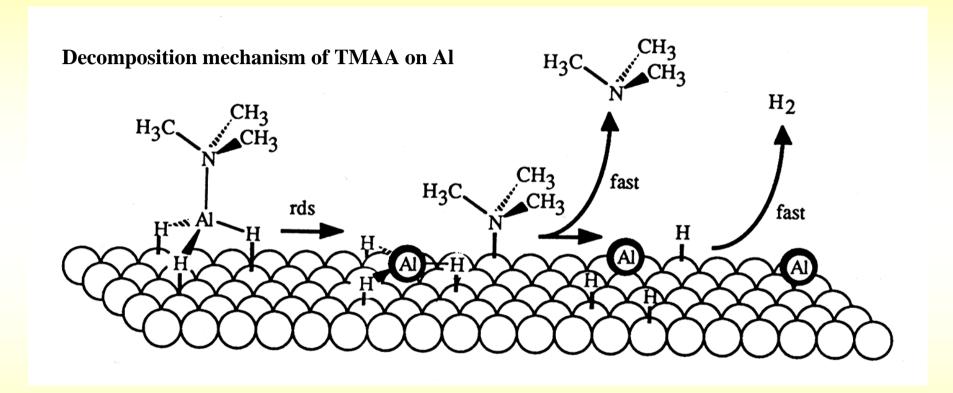
large carbon incorporation, Al₄C₃, RF plasma, laser

$$Al_2(CH_3)_6 \longrightarrow 1/2 Al_4C_3 + 9/2 CH_4$$
 under N_2

$$Al_2(CH_3)_6 + 3H_2 \longrightarrow 2Al + 6CH_4$$
 under H_2

TMAA

$$(CH_3)_3N-AlH_3 \longrightarrow Al + (CH_3)_3N + 3/2 H_2$$
 below 100 °C



$$(CH_3)_3N-AlH_3 \longrightarrow Al + (CH_3)_3N + 3/2 H_2$$
 below 100 °C

Aluminoboranes

$$H_{3}C$$
 CH_{3}
 H_{4}
 $H_$

DMAH

ligand redistribution

$$[(CH_3)_2AlH]_3 \longrightarrow (CH_3)_3Al \uparrow + AlH_3 \longrightarrow Al + H_2$$

at 280 °C, low carbon incorporation

Tungsten

5.6 $\mu\Omega$ cm, a high resistance to electromigration, the highest mp of all metals 3410 °C.

$$2 WF_6 + 3 Si \rightarrow 2 W + 3 SiF_4$$

$$WF_6 + 3H_2 \rightarrow W + 6HF$$

$$WF_6 + 3/2 SiH_4 \rightarrow W + 3 H_2 + 3/2 SiF_4$$

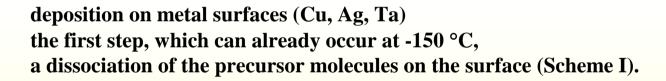
$$W(CO)_6 \rightarrow W + 6 CO$$

Diketonate ligands

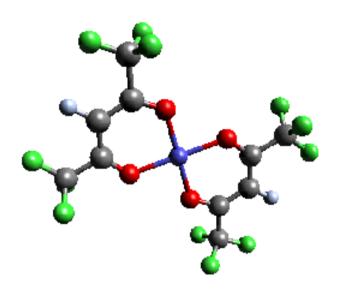
R ₁	R ₂	Name	Abbreviation
CH ₃	CH ₃	Pentane-2,4-dionate (acetylacetonate)	acac
CH ₃	CF ₃	1,1,1-trifluoropentane-2,4-dionate (trifluoroacetylacetonate)	tfac
CF ₃	CF ₃	1,1,1,5,5,5-hexafluoropentane-2,4-dionate (hexafluoroacetylacetonate)	hfac
CH ₃	C(CH ₃) ₃	1,1-dimethylhexane-3,5-dionate	dhd
C(CH ₃) ₃	C(CH ₃) ₃	2,2,6,6-tetramethylheptane-3,5-dionate	thd
CH ₃	CH ₂ CH(CH ₃) ₂	6-methylheptane-2,4-dionate	mhd
C(CH ₃) ₃	CH ₂ CH(CH ₃) ₂	2,2,7-trimethyloctane-3,5-dionate	tmod
C ₆ H ₅	C ₆ H ₅	1,3-diphenylpropane-1,3-dionate (dibenyzoylmethanate)	dbm

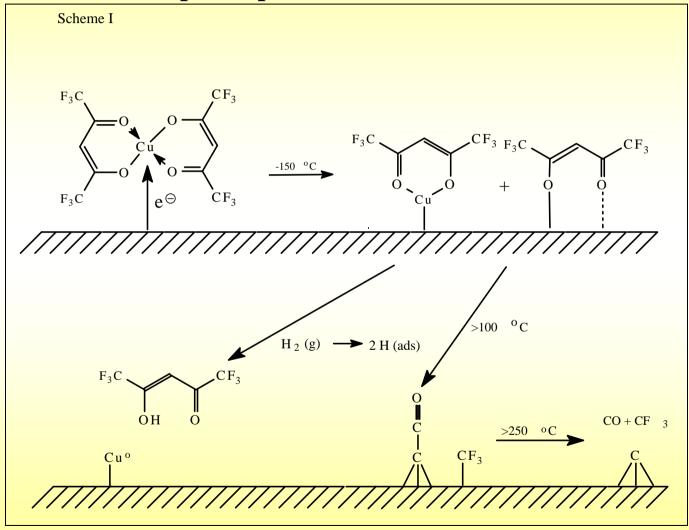
Copper(II) hexafluoroacetylacetonate

excellent volatility (a vapor pressure of 0.06 Torr at r. t.), low decomposition temperature, stability in air, low toxicity, commercial availability

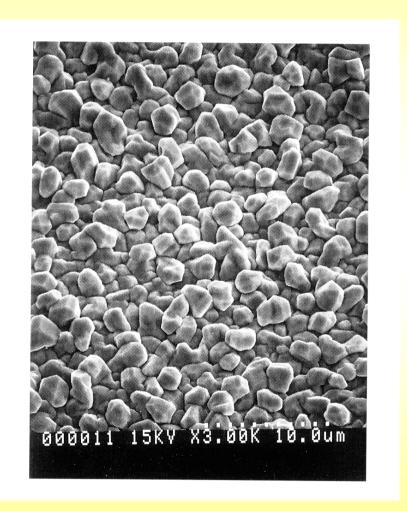


An electron transfer from a metal substrate to the single occupied HOMO which has an anti-bonding character with respect to copper d_{xy} and oxygen p orbitals weakens the Cu-O bonds and facilitates their fission.

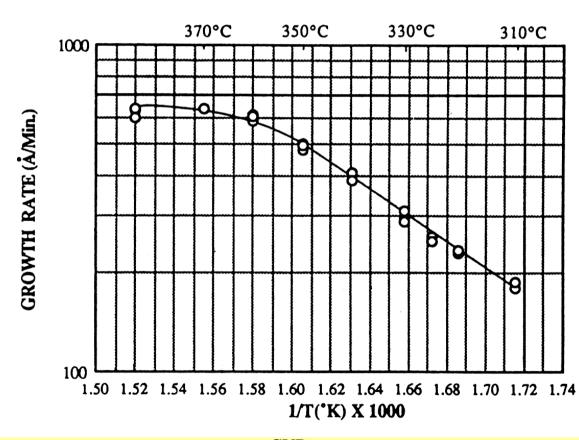




SEM of Cu film, coarse grain, high resistivity



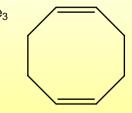
Growth rate of Cu films deposited from Cu(hfacac)₂ with 10 torr of H₂



Cu(I) precursors

Disproportionation to Cu(0) and Cu(II)

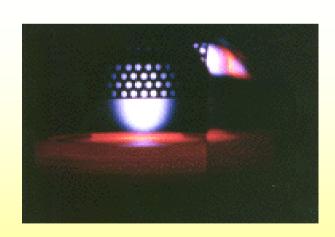
 $2 \; Cu(diketonate) L_n \rightarrow \; \; Cu \; + \; \; Cu(diketonate)_2 \; + \; n \; L$

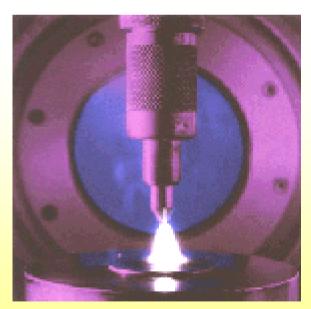


Diamond films

activating gas-phase carbon-containing precursor molecules:

- •thermal (e.g. hot filament)
- •plasma (D.C., R.F., or microwave)
- •combustion flame (oxyacetylene or plasma torches)





Experimental conditions:

temperature 1000-1400 K

the precursor gas diluted in an excess of hydrogen (typical CH₄ mixing ratio ~1-2vol%)

Deposited films are polycrystalline

Film quality:

- •the ratio of sp³ (diamond) to sp²-bonded (graphite) carbon
- •the composition (e.g. C-C versus C-H bond content)
- •the crystallinity

Combustion methods: high rates (100-1000 µm/hr), small, localised areas, poor quality films.

Hot filament and plasma methods: slower growth rates (0.1-10 μ m/hr), high quality films.

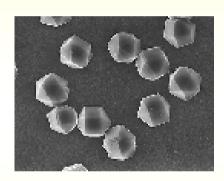
Hydrogen atoms generated by activation (thermally or via electron bombardment)
H-atoms play a number of crucial roles in the CVD process:

H abstraction reactions with hydrocarbons, highly reactive radicals: CH₃ (stable hydrocarbon molecules do not react to cause diamond growth) radicals diffuse to the substrate surface and form C-C bonds to propagate the diamond lattice.

H-atoms terminate the 'dangling' carbon bonds on the growing diamond surface, prevent cross-linking and reconstructing to a graphite-like surface.

Atomic hydrogen etches both diamond and graphite but, under typical CVD conditions, the rate of diamond growth exceeds its etch rate whilst for graphite the converse is true. This is the basis for the preferential deposition of diamond rather than graphite.

Diamond initially nucleates as individual microcrystals,
which then grow larger until they coalesce into a continuous film



Enhanced nucleation by ion bombardment:
damage the surface - more nucleation sites
implant ions into the lattice
form a carbide interlayer - glue, promotes diamond growth, aids adhesion

Substrates: metals, alloys, and pure elements:

Little or no C Solubility or Reaction: Cu, Sn, Pb, Ag, and Au, Ge, sapphire, diamond, graphite

C Diffusion: Pt, Pd, Rh, Fe, Ni, and Ti

the substrate acts as a carbon sink, deposited carbon dissolves into the metal surface, large amounts of C transported into the bulk,

a temporary decrease in the surface C concentration, delaying the onset of nucleation

Carbide Formation: Ti, Zr, Hf, V, Nb, Ta, Cr, Mo, W, Fe, Co, Ni, Y, Al

B, Si, SiO₂, quartz, Si₃N₄ also form carbide layers.

SiC, WC, and TiC

Applications of diamond films:

Thermal management - a heat sink for laser diodes, microwave integrated circuits active devices mounted on diamond can be packed more tightly without overheating

Cutting tools - an abrasive, a coating on cutting tool inserts

CVD diamond-coated tools have a longer life, cut faster and provide a better finish than conventional WC tool bits

Wear Resistant Coatings -protect mechanical parts, reduce lubrication gearboxes, engines, and transmissions

Optics - protective coatings for infrared optics in harsh environments,

ZnS, ZnSe, Ge: excellent IR transmission but brittle

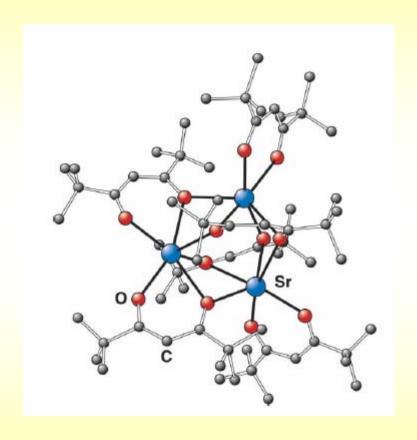
the flatness of the surface, roughness causes attenuation and scattering of the IR signal

Electronic devices - doping, an insulator into a semiconductor

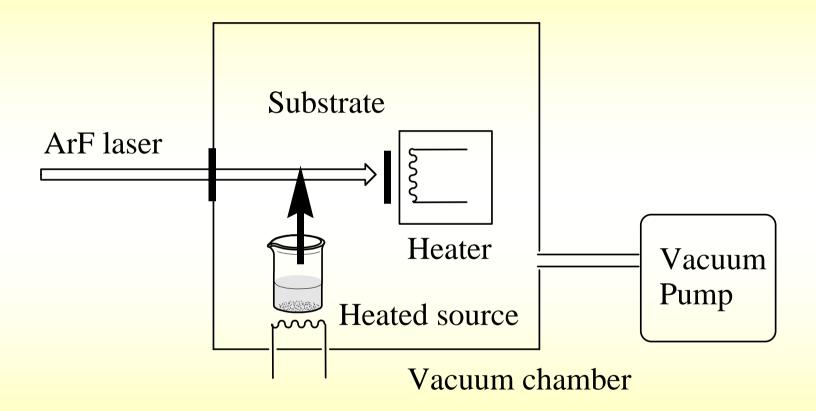
p-doping: B₂H₆ incorporates B into the lattice

doping with atoms larger than C very difficult, n-dopants such as P or As, cannot be used

for diamond, alternative dopants, such as Li



Laser-enhaced CVD



$$Si(O_2CCH_3)_4 \rightarrow SiO_2 + 2 O(OCCH_3)_2$$